Notice of References Cited Application/Control No. 10/015,598 Applicant(s)/Patent Under Reexamination SHIZUKUISHI, MAKOTO Examiner Chriss S. Yoder, III Applicant(s)/Patent Under Reexamination SHIZUKUISHI, MAKOTO Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,210,433 A	05-1993	Ohsawa et al.	257/250
	В	US-6,618,087 B1	09-2003	Hokari et al.	348/311
	С	US-5,844,290 A	12-1998	Furumiya, Masayuki	257/432
	D	US-5,682,203 A	10-1997	Kato, Masatake	348/340
	Ε	US-4,810,619	03-1989	Pampalone et al.	430/313
	F	US-6,822,682 B1	11-2004	Kawajiri et al.	348/315
	G	US-4,680,636	07-1987	Ooi, Kazushige	348/317
	Н	US-6,606,124 B1	08-2003	Hatano et al.	348/311
	1	US-4,242,700	12-1980	Weimer, Paul K.	348/275
	J	US-6,806,904 B1	10-2004	Kim, Yong Gwan	348/315
	к	US-6,344,666 B1	02-2002	Yamaguchi et al.	257/98
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р			,		
	Q					
	R					
	ø					
	Τ					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	V						
	V						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.